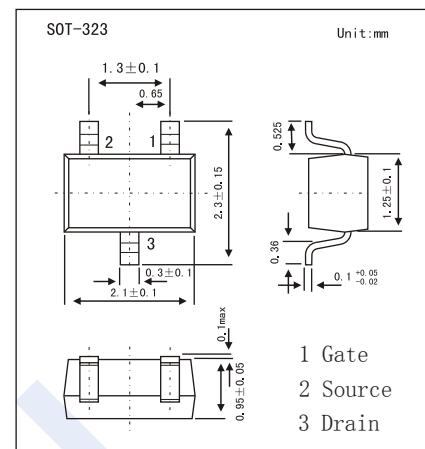
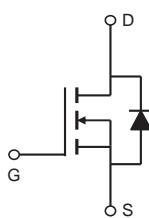


## N-Channel MOSFET

### 2KK5044

#### ■ Features

- $V_{DS} (V) = 20V$
- $I_D = 2.1 A (V_{GS} = 10V)$
- $R_{DS(ON)} < 55m\Omega (V_{GS} = 10V)$
- $R_{DS(ON)} < 65m\Omega (V_{GS} = 4.5V)$
- $R_{DS(ON)} < 85m\Omega (V_{GS} = 2.5V)$



#### ■ Absolute Maximum Ratings $T_a = 25^\circ C$

Parameter		Symbol	Rating	Unit
Drain-Source Voltage	$T_a=25^\circ C$	$V_{DS}$	20	V
Gate-Source Voltage		$V_{GS}$	$\pm 12$	
Continuous Drain Current	$T_a=25^\circ C$	$I_D$	2.1	A
	$T_a=70^\circ C$		1.5	
Pulsed Drain Current		$I_{DM}$	15	W
Power Dissipation	$T_a=25^\circ C$	$P_D$	0.35	
	$T_a=70^\circ C$		0.22	
Thermal Resistance.Junction- to-Ambient	$t \leq 10s$	$R_{thJA}$	360	$^\circ C/W$
	Steady-State		425	
Thermal Resistance.Junction- to-Case		$R_{thJC}$	320	$^\circ C$
Junction Temperature		$T_J$	150	
Storage Temperature Range		$T_{stg}$	-55 to 150	

## N-Channel MOSFET

### 2KK5044

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =250 μ A, V <sub>GS</sub> =0V	20			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V			1	uA
		V <sub>DS</sub> =20V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C			5	
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250 μ A	0.5	1	1.5	V
Static Drain-Source On-Resistance	R <sub>D(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =2.1A			55	mΩ
		V <sub>GS</sub> =10V, I <sub>D</sub> =2.1A T <sub>J</sub> =125°C			84	
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =1.5A			65	
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =1A			85	
On State Drain Current	I <sub>D(on)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =5V	15			A
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =5V, I <sub>D</sub> =2.1A		14		S
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz		235		pF
Output Capacitance	C <sub>oss</sub>			35		
Reverse Transfer Capacitance	C <sub>rss</sub>			18		
Gate Resistance	R <sub>G</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz		4.3		Ω
Total Gate Charge (10V)	Q <sub>g</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =2.1A		10		nC
Total Gate Charge (4.5V)				4.7		
Gate Source Charge	Q <sub>gs</sub>			0.95		
Gate Drain Charge	Q <sub>gd</sub>			1.6		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =8 Ω , R <sub>GEN</sub> =3 Ω		3.5		ns
Turn-On Rise Time	t <sub>r</sub>			1.5		
Turn-Off Delay Time	t <sub>d(off)</sub>			17.5		
Turn-Off Fall Time	t <sub>f</sub>			2.5		
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 2.1A, dI/dt= 100A/μ s		8.5	11	nC
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			2.6	3.5	
Maximum Body-Diode Continuous Current	I <sub>s</sub>				1.5	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>s</sub> =1A, V <sub>GS</sub> =0V			1	V

## N-Channel MOSFET

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#### ■ Typical Characteristics

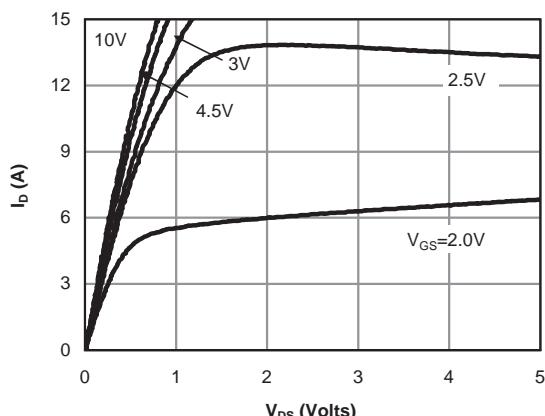


Fig 1: On-Region Characteristics

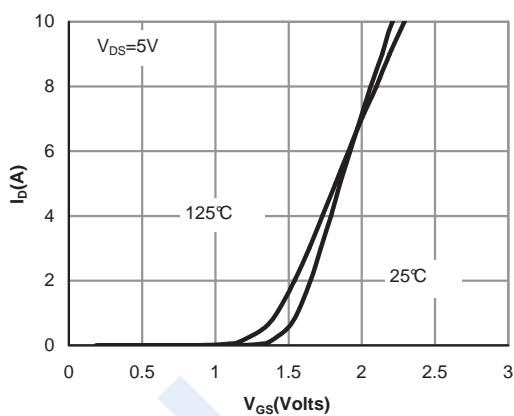


Figure 2: Transfer Characteristics

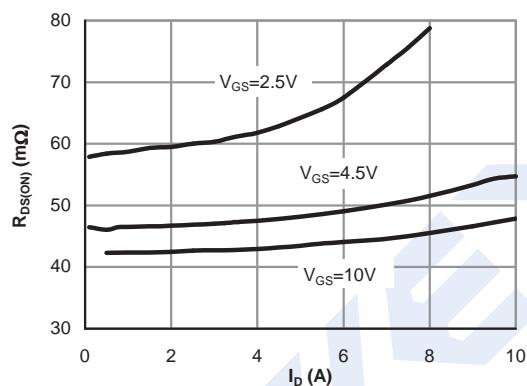


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

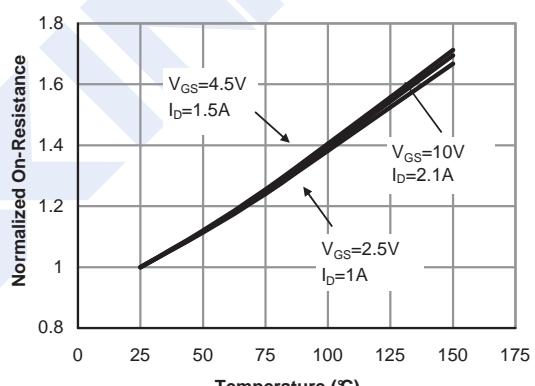


Figure 4: On-Resistance vs. Junction Temperature

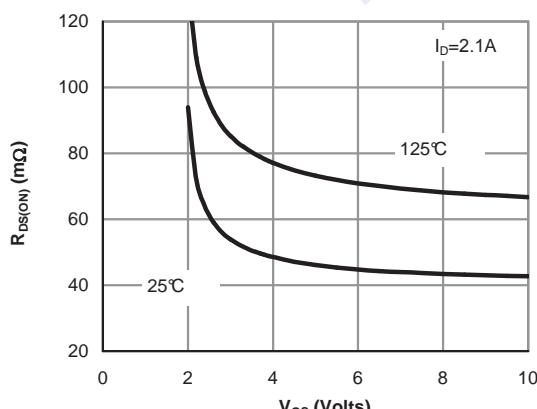


Figure 5: On-Resistance vs. Gate-Source Voltage

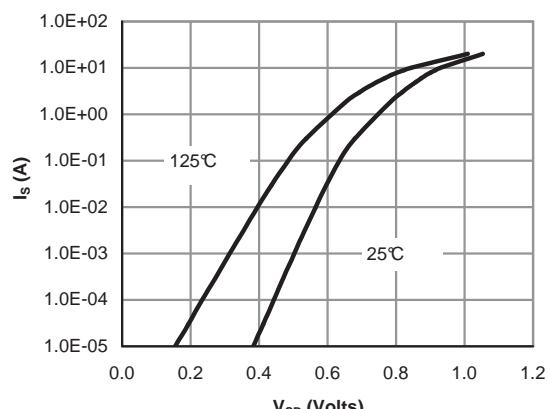


Figure 6: Body-Diode Characteristics

## N-Channel MOSFET

### 2KK5044

#### ■ Typical Characteristics

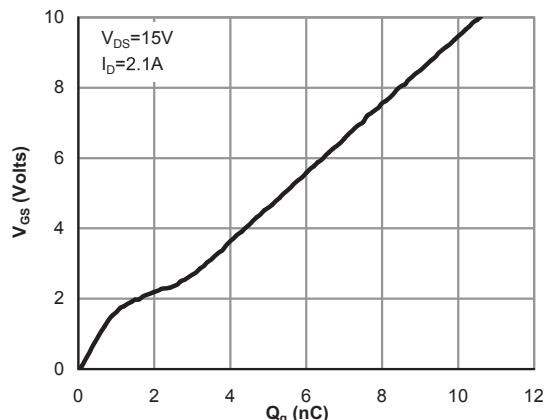


Figure 7: Gate-Charge Characteristics

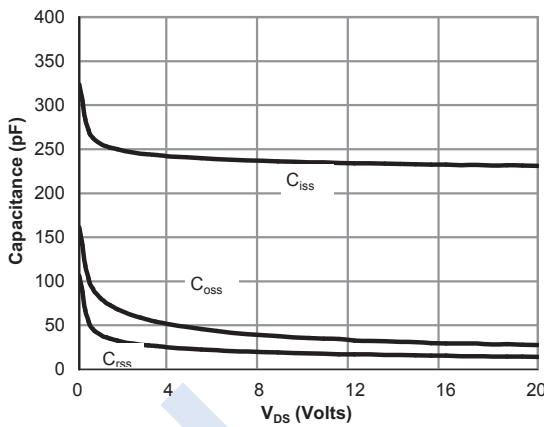


Figure 8: Capacitance Characteristics

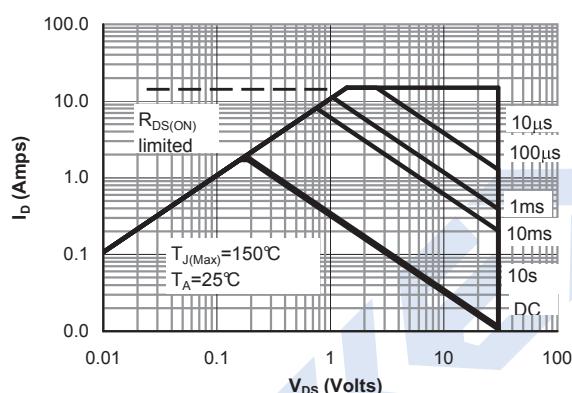


Figure 9: Maximum Forward Biased Safe Operating Area

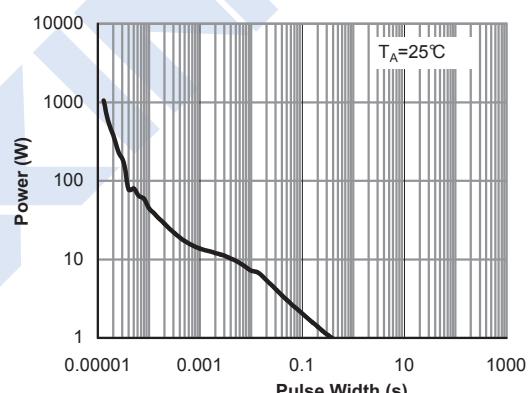


Figure 10: Single Pulse Power Rating Junction-to-Ambient

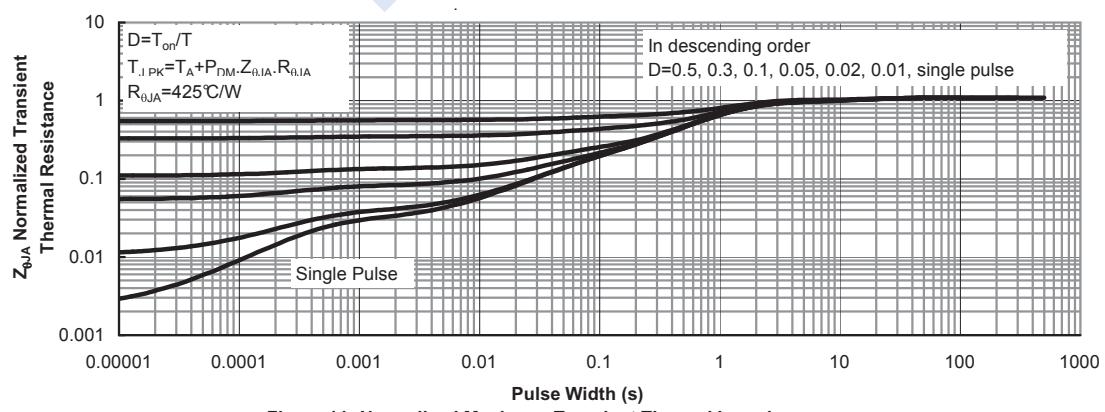


Figure 11: Normalized Maximum Transient Thermal Impedance